

<b>Notice of References Cited</b>	Application/Control No. 10/599,661		Applicant(s)/Patent Under Reexamination SEKI ET AL.	
	Examiner YU CHEN		Art Unit 2815	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,958,607	09-1999	Kim et al.	428/675
*	C	US-7,268,415 B2	09-2007	Abbott et al.	257/666
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	KR 2003003566 A	01-2003	Korea, Republic	CHAE S T et al.	
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#### NON-PATENT DOCUMENTS

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	U	Chae et al. (Machine Translation of KR2003-003566A)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.